

**Notice of References Cited**Application/Control No.  
09/930,183Applicant(s)/Patent Under  
Reexamination  
OOE ET AL.Examiner  
Tom V ShengArt Unit  
2673

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6529204 B1	03-2003	Mikoshiba et al.	345/597
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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